SCAS141A - AUGUST 1989 - REVISED AUGUST 1995

- Flow-Through Architecture Optimizes PCB Layout
- Center-Pin V_{CC} and GND Configurations Minimize High-Speed Switching Noise
- EPIC[™] (Enhanced-Performance Implanted CMOS) 1-μm Process
- 500-mA Typical Latch-Up Immunity at 125°C
- Package Options Include Plastic Small-Outline (DW) Packages, Ceramic Chip Carriers (FK) and Flatpacks (W), and Standard Plastic (N) and Ceramic (J) DIPs

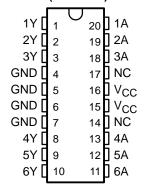
description

The 'AC11014 contains six independent inverters. They perform the Boolean function $Y = \overline{A}$. Because of the Schmitt action, the devices have different input threshold levels for positive-going (V_{T+}) and for negative-going (V_{T+}) signals.

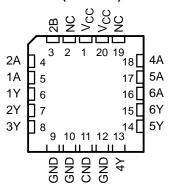
These circuits are temperature compensated. They can be triggered from the slowest of input ramps and still give clean, jitter-free output signals and greater noise margin than conventional inverters.

The 54AC11014 is characterized for operation over the full military temperature range of -55°C to 125°C. The 74AC11014 is characterized for operation from -40°C to 85°C.

54AC11014 ... J OR W PACKAGE 74AC11014 ... DW OR N PACKAGE (TOP VIEW)



54AC11014 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

FUNCTION TABLE (each inverter)

	<u> </u>
INPUT	OUTPUT
Α	Υ
Н	L
L	Н

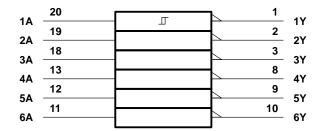


Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

EPIC is a trademark of Texas Instruments Incorporated.



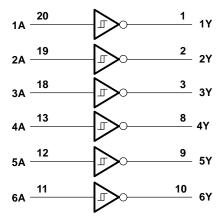
logic symbol†



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for the DW, J, N, and W packages.

logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, V _{CC}	0.5 V to 7 V
Input voltage range, V _I (see Note 1)	$-0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Output voltage range, V _O (see Note 1)	$-0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)	±20 mA
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{CC})	±50 mA
Continuous output current, $I_O(V_O = 0 \text{ to } V_{CC})$	±50 mA
Continuous current through V _{CC} or GND	±150 mA
Storage temperature range, T _{stg}	–65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

recommended operating conditions

			54	AC1101	74AC11014		74AC11014			
			MIN NOM MAX MIN NOM				MAX	AX UNIT		
Vcc	Supply voltage		3	5	5.5	3	5	5.5	V	
	VCC = 3 V	2.1			2.1					
V_{IH}	H High-level input voltage	V _{CC} = 4.5 V	3.15			3.15			V	
	$V_{CC} = 5.5 \text{ V}$	3.85			3.85					
		VCC = 3 V			0.9			0.9		
V_{IL}	V _{IL} Low-level input voltage	V _{CC} = 4.5 V			1.35			1.35	V	
		$V_{CC} = 5.5 \text{ V}$			1.65		-	1.65		
٧ _I	Input voltage		0		VCC	0		Vcc	V	
٧o	Output voltage		0		Vcc	0		Vcc	V	
		VCC = 3 V			-4			-4		
loh	High-level output current	VCC = 4.5 V			-24			-24	mA	
		V _{CC} = 5.5 V			-24			-24		
I _{OL} L		V _{CC} = 3 V			12		-	12		
	Low-level output current	V _{CC} = 3 V			24		-	24	mA	
		V _{CC} = 5.5 V			24			24		
T _A	Operating free-air temperature		-55		125	-40	-	85	°C	



SCAS141A - AUGUST 1989 - REVISED AUGUST 1995

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	vcc	T,	_A = 25°C	54AC	11014	74AC11014		UNIT	
PARAMETER	1201 00110110110		MIN	TYP MAX	MIN	MAX	MIN	MAX	UNIT	
VT+		3 V		2.2		2.2		2.2		
Positive-going		4.5 V		3.2		3.2		3.2	V	
threshold		5.5 V		3.9		3.9		3.9		
V _T _		3 V	0.5		0.5		0.5			
Negative-going		4.5 V	0.9		0.9		0.9		V	
threshold		5.5 V	1.1		1.1		1.1			
ΔVT		3 V	0.3	1.2	0.3	1.2	0.3	1.2		
Hysteresis		4.5 V	0.4	1.4	0.4	1.4	0.4	1.4	V	
$(V_{T+}^{\prime}-V_{T-})$		5.5 V	0.5	1.6	0.5	1.6	0.5	1.6		
		3 V	2.9		2.9		2.9			
	ΙΟΗ = – 50 μΑ	4.5 V	4.4		4.4		4.4		V	
		5.5 V	5.4		5.4		5.4			
	I _{OH} = – 4 mA	3 V	2.58		2.4		2.48			
VOH	I _{OH} = -24 mA	4.5 V	3.94		3.7		3.8			
		5.5 V	4.94		4.7		4.8			
	I _{OH} = - 50 mA [†]	5.5 V			3.85					
	I _{OH} = -75 mA [†]	5.5 V					3.85		\neg	
	Ι _{ΟL} = 50 μΑ	3 V		0.1		0.1		0.1		
		4.5 V		0.1		0.1		0.1		
		5.5 V		0.1		0.1		0.1		
V	I _{OL} = 12 mA	3 V		0.36		0.5		0.44	V	
VOL	I _{OL} = 24 mA	4.5 V		0.36		0.5		0.44	V	
		5.5 V		0.36		0.5		0.44		
	I _{OL} = 50 mA [†]	5.5 V				1.65				
	I _{OL} = 75 mA [†]	5.5 V						1.65		
lį	V _I = V _{CC} or GND	5.5 V		±0.1		±1		±1	μΑ	
ICC	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V		4		80		40	μА	
C _i	V _I = V _{CC} or GND	5 V		3.5					pF	

[†] Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	T,	4 = 25°C	;	54AC1	11014	74AC1	1014	UNIT
	(INPUT) (OUTPU	(INPUT) (OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
t _{PLH}	Δ.	V	1.2	5.4	9.2	1.2	10.3	1.2	9.8	20
^t PHL	A	T	1.7	6	8.5	1.7	9.9	1.7	9.3	ns



SCAS141A - AUGUST 1989 - REVISED AUGUST 1995

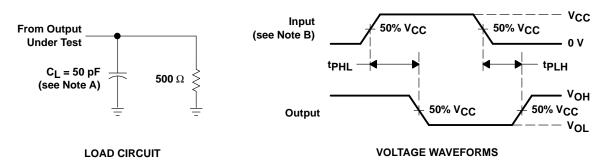
switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	T,	4 = 25°C	;	54AC1	11014	74AC1	1014	UNIT
PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNII
^t PLH	Δ.	V	1.1	3.6	6.8	1.1	7.6	1.1	7.1	20
tPHL	A	ī	1.5	4.1	6.7	1.5	7.6	1.5	7.4	ns

operating characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$

PARAMETER	TEST CONDITIONS	TYP	UNIT
C _{pd} Power dissipation capacitance	$C_L = 50 \text{ pF}, f = 1 \text{ MHz}$	27	pF

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50 \Omega$, $t_f = 3 \text{ ns}$, $t_f = 3 \text{ ns}$.
- C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

IMPORTANT NOTICE

Texas Instruments (TI) reserves the right to make changes to its products or to discontinue any semiconductor product or service without notice, and advises its customers to obtain the latest version of relevant information to verify, before placing orders, that the information being relied on is current.

TI warrants performance of its semiconductor products and related software to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

Certain applications using semiconductor products may involve potential risks of death, personal injury, or severe property or environmental damage ("Critical Applications").

TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, INTENDED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT APPLICATIONS, DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS.

Inclusion of TI products in such applications is understood to be fully at the risk of the customer. Use of TI products in such applications requires the written approval of an appropriate TI officer. Questions concerning potential risk applications should be directed to TI through a local SC sales office.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards should be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance, customer product design, software performance, or infringement of patents or services described herein. Nor does TI warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used.

Copyright © 1996, Texas Instruments Incorporated